



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Sharad Kapur, et al.

RECEIVED

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Serial No.:

09/427,238

Technology Center 2100

Filed:

October 26, 1999

For:

SYSTEM AND METHOD FOR DETERMINING CAPACITANCE

FOR LARGE-SCALE INTEGRATED CIRCUITS

Group No.:

2123

Examiner:

Eduardo Garcia-Otero

Commissioner for Patents Washington, D. C. 20231

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, Washington, D.C. 20231, on

Stephanie Pritt

(Printed or typed name of person signing the certificate

Sir:

## **PRELIMINARY AMENDMENT**

Before re-examination of the above-identified application, please amend it as set forth below.